

Search Notes 	Application/Control No. 10/643,404	Applicant(s)/Patent under Reexamination TANAKA ET AL.
	Examiner Brian S. Kwon	Art Unit 1614

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
514	404	7/26/2007	BK
	406		
	443		
514/469,471,412,427			